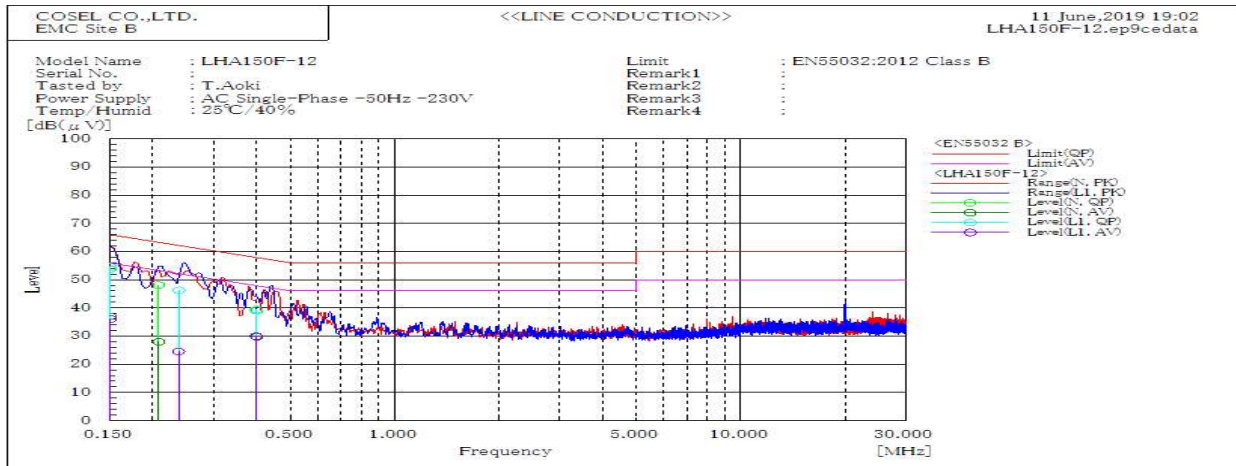
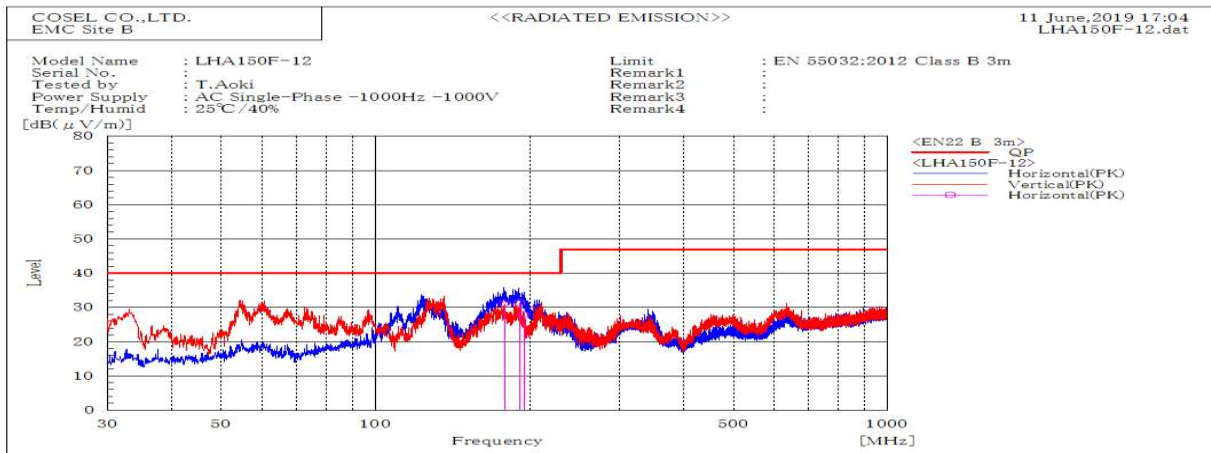


DATA SHEET		Date	12-Sep-19
Model	LHA150F-12	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Aoki



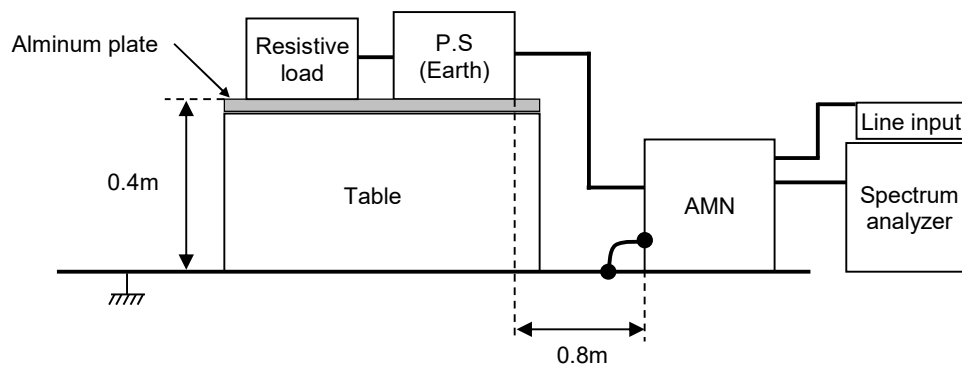
Frequency MHz	Line	Level dB(μV)		Limit dB(μV)		Margin dB		Pass/Fail	Remark
		QP	AV	QP	AV	QP	AV		
0.151	L1	54.5	36.1	66	56	11.5	19.9	Pass	
0.238	L1	46.3	24.5	62.2	52.2	15.9	27.7	Pass	
0.398	L1	39.5	30	57.9	47.9	18.4	17.9	Pass	
0.15	N	53.8	37.1	66	56	12.2	18.9	Pass	
0.208	N	48.1	28	63.3	53.3	15.2	25.3	Pass	
0.4	N	39.1	29.7	57.8	47.8	18.7	18.1	Pass	



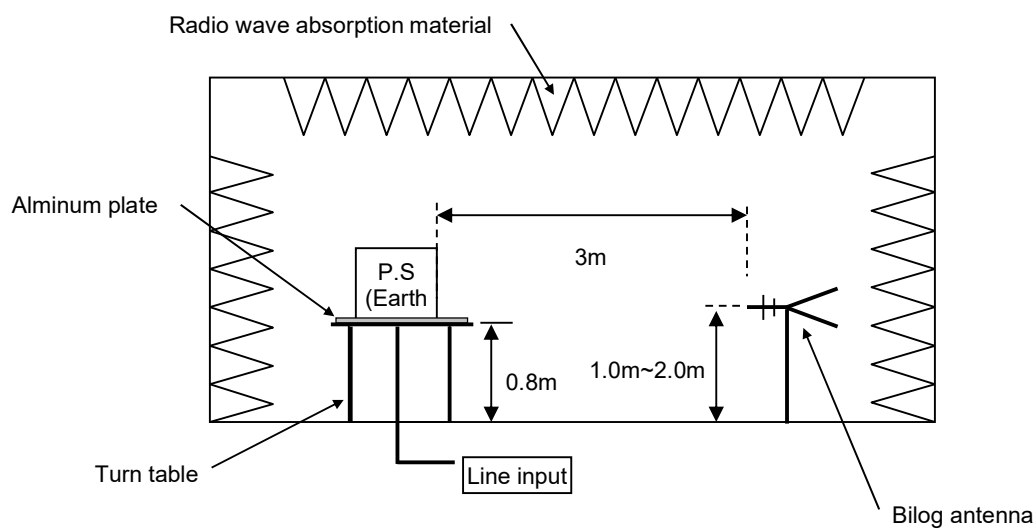
Frequency MHz	Polarization	Stability	Level dB(μV/m)	Limit dB(μV/m)	Margin dB	Pass/Fail	Height cm	Angle deg	Remark
			QP	QP	QP				
178.83	H	Stable	31.3	40	8.7	Pass	199.7	19.4	
190.955	H	Stable	31.4	40	8.6	Pass	199.4	174	
194.798	H	Stable	27.9	40	12.1	Pass	199.1	0	

DATA SHEET		Date	12-Sep-19
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Aoki

## 1. Line conduction



## 2. Radiated emission

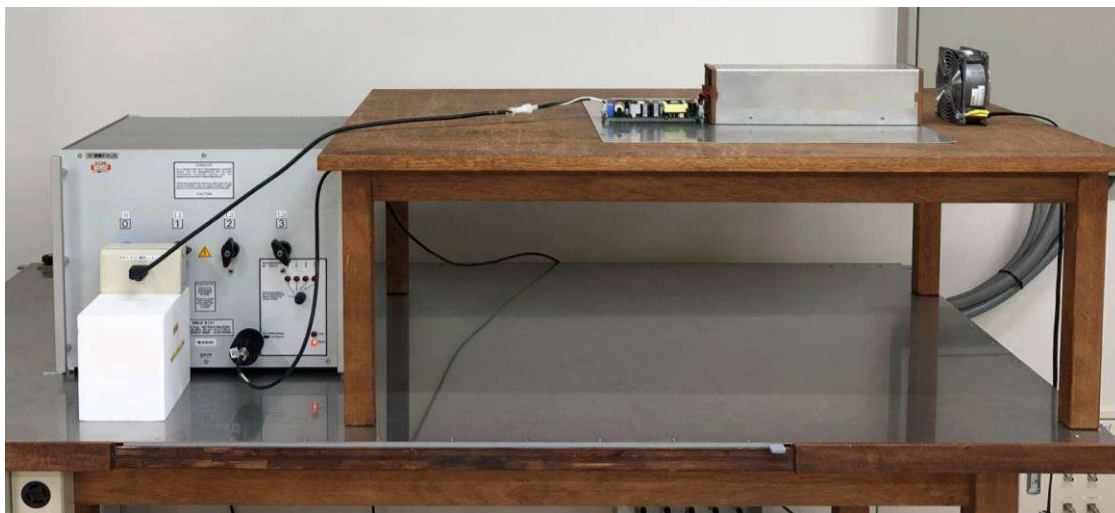


## Conditions

Test : EMI  
Model Name : LHA150F-12

## Photographs of test set-up

### 1.LINE CONDUCTION



### 2.RADIATED EMISSION

